

# ICT - Collaborative Project

# **NANOBITS**

## Exchangeable and Customizable Scanning Probe Tips

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**Duration: 36 months** 

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Dissemination Level				
PU	Public	Х		
PP	Restricted to other programme participants (including the Commission Services)			
RE	Restricted to a group specified by the consortium (including the Commission Services)			
СО	Confidential, only for members of the consortium (including the Commission Services)			

## Deliverable Report



### **Document Information**

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#### 1. Summary description of the deliverable content and purpose

This deliverable lists the NanoBits publications from the first reporting period M1 – M12.

The published papers and other releases can also be found on the NanoBits website http://www.nanobits-project.eu/index.php/nanobits-publications.

In preparation of the project, 1 journal paper was published and in the first reporting period there were 3 conference papers and 1 press release.

#### 2. Deliverable Report

#### 2.1 Publications of first reporting period M1 – M12

#### Journal Paper:

R.T. Rajendra Kumar, S.U. Hassan, O. Sardan, V. Eichhorn, F. Krohs, S. Fatikow, P. Bøggild: "Nanobits: customisable scanning probe tips", Nanotechnology, Vol. 20, No. 39, pp. 395703, 2009.

#### • Conference Paper:

V. Eichhorn, D. Jasper, F. Krohs, P. Bøggild, S. Fahlbusch, M. Oliva, O. Krause, H. Haschke and S. Fatikow: "NanoBits: Exchangeable and customizable scanning probe tips as a versatile tool for nanoscale applications", in Proc. of the 7th International Workshop on Microfactories (IWMF 2010), Daejeon, Korea, 24-27 October, 2010.

M. Bartenwerfer, V. Eichhorn, D. Jasper, S. Fatikow, A. Savenko, D. H. Petersen, B. Malm, and P. Bøggild: "Automated Handling and Assembly of Customizable AFM-Tips", in Proc. of the International Symposium on Assembly and Manufacturing (ISAM 2011), Tampere, Finland, 25-27 May 2011.

A. Savenko, P. Bøggild, B. Malm, D.H. Petersen, I. Yildiz, "High precision FIB fabrication of customizable AFM probes", in Proc. of the 55th International Conference on Electron, Ion, and Photon Beam Technology and Nanofabrication (EIPBN-2011), Las Vegas, USA, May 31 - June 3 2011.

#### Press Release:

NMN Materialkompass: Nano- und Materialinnovationen Niedersachsen, April 2011, page 10 http://www.nmn-ev.de/blobs/nmn\_materialkompass.pdf?pb-id=wd124f9620f3643f7b3ed52cabe12bcef4a8624a54c